Search Notes

Applicati	ion/Co	ntrol	Νo.
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10/749,246 Examiner

Yonel Beaulieu

Applicant(s)/Patent under Reexamination

CHOI, JANG-DON

Art Unit

3661

SEARCHED					
Class	Subclass	Date	Examiner		
701	200-202	7/23/2005	YB		
	208				
	209				
	23				
	25				
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST & Inventor's Name Search	7/24/2005	ΥB	